

6th International “Hiroshima” Symposium on the Development and
Application of Semiconductor Tracking Detectors (STD6)
STD6 website



Contribution ID: 90

Type: **not specified**

Annealing of effective trapping times in irradiated silicon detectors

Thursday, 14 September 2006 08:40 (20 minutes)

Author: KRAMBERGER, Gregor

Presenter: KRAMBERGER, Gregor